

LSB such that the comparison is triggered only when the higher order of bits are equal. The comparison resolution module encodes the comparison bits into two buses that is left bus and right bus such that each bus stores the partial comparison result as each bit is compared such that

- If $A_n > B_n$ then left $n = 1$ and right $n = 0$
- $A_n > B_n$ then left $n = 0$ and right $n = 1$
- $A_n = B_n$ then left $n = 0$ and right $n = 0$

The decision module uses or-network to make a final comparison decision based on the bits of left bus and rights bus.

- If $l_r = 00$ then $A = B$
- $l_r = 01$ then $A < B$
- $l_r = 10$ then $A > B$

II. COMPARATOR ARCHITECTURE

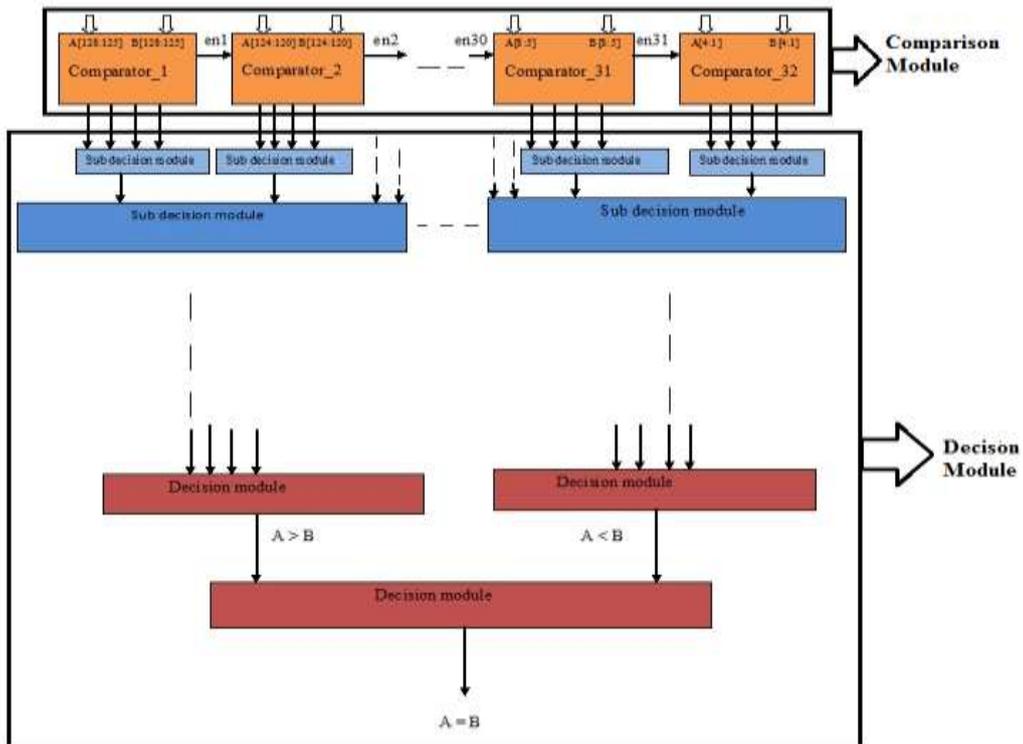


Figure2: 128 Bit Comparator Architecture

The comparator architecture consists of comparison module and the decision module. The comparison module performs the comparison of the give input bits. As we are designing a 128 bit comparator the 128 bits are grouped into 4 bits and each four bits are compared in a single module and we have 32 modules each comparing 4 bits. Each 4 bit comparator module takes two 4 bit input operands one enable signal from the previous comparator module. This enable signal helps in triggering the present module for comparison. Each 4 bit comparator module has 4 outputs that are associated with the decision module and one enable output that acts as enable input for the next comparator module for comparison. The decision module gets its input from the comparison module. Each comparison module gives 4 outputs for 4 input bits. In this way we get a total of 128 outputs from the comparison module each single output for 128 inputs. Each four inputs are combined to get a single output. This procedure is followed until we get our final 3 outputs which are A greater than B ($A > B$), A less than B ($A < B$), A equal to B ($A = B$). Each 4 bit comparator module of the comparison module is again divided into five hierarchical set elements that perform the comparison operation in a serial manner. We partition the comparator resolution module structure into five hierarchal prefixing sets.

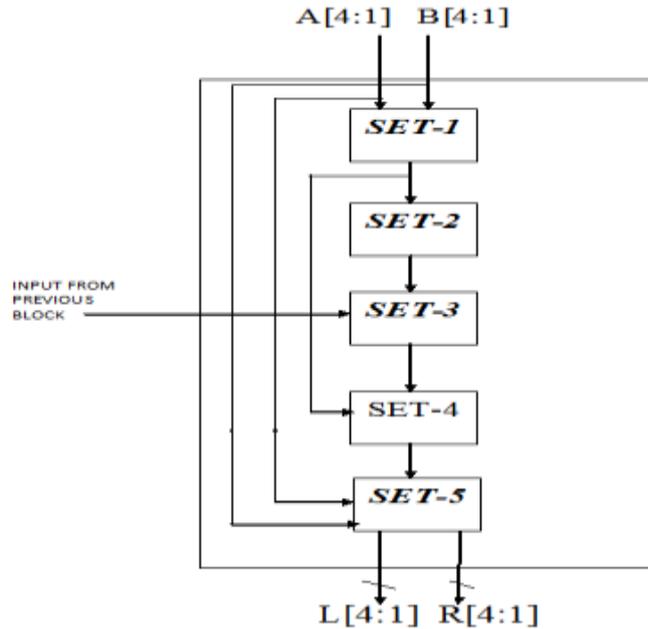


Figure3: Tree structure of comparison module

III. COMPARATOR DESIGN

The comparison module performs bitwise comparison using a tree structure. In the comparison module we use five Sets of elements. Each set performs an individual operation of comparison. Set -1 performs comparison of two individual bits of A and B. The output of set-1 acts as the input of set-2 .set-2 combines the output of four set-1 outputs. The output of set-2 acts as input to set-3. The output of set-3 acts as enable input to set-4 elements. The output of set-4 element acts as enable input to set-5 element. The output of set-5 element forms right and left bus bits. The right and left bus bits from the comparison module are given to the decision module which performs or-operation and decides whether A is greater than B or A is less than B or A is equal to B.

Set 1 compares the N -bit operands A and B bit-by-bit, using a single level of set 1 type cells. The set_1 type cells provide a termination flag D_i to cells in sets 2 and 4, indicating whether the computation should terminate or to proceed. These cells compute XOR operation.

$$D_i = A_i \oplus B_i$$

Set 2 consists of set_2 type cells, which combine the termination flags for each of the four cells from set 1 (each_2-type cell combines the termination flags of one 4-b partition) using NOR-logic to limit the fan-in and fan-out to a maximum of four. The set_2 type cells either continue the comparison for bits of lesser significance if all four inputs are 0s, or terminate the comparison if a final decision can be made. For $0 \leq m \leq N/4-1$, there is a total of $N/4$ set_2-type cells, all functioning in parallel

$$S_{2,m} = \overline{(D_{m,1} \cdot D_{m,2} \cdot D_{m,3} \cdot D_{m,4})}$$

Set 3 consists of set_3-type cells, which are similar to set_2 type cells, but can have more logic levels, different inputs, and carry different triggering points. Set_3 type cells provide no comparison functionality. The cell's sole purpose is to limit the fan-in and fan-out regardless of operand bit width. To limit the set_3-type cell's, the number of levels in set 3 increases if the fan-in exceeds four. Set 3 provides functionality similar to set 2 using the AND logic to continue or terminate the bitwise comparison activity. If the comparison is terminated, set 3 signals set 4 to set the left bus and right bus bits to 0 for all bits of lower significance. For $0 \leq m \leq N/4 - 1$, there is a total of $N/4$ set_3 type cells per level. From left to right, the first four set_3 type cells in set 3 combine the 4-b partition comparison outcomes from the one, two, three, and four 4-b partitions of set 2. Since the fourth set_3 type cell has a fan-in of four, the number of levels in set 3 increases and set 3's fifth cell combines the comparison outcomes of the first 16 MSBs with a fan-in of only two and a fan-out of one.

$$S_{3,m} = S_{2,m-1} \cdot S_{2,m}$$

Where m indicates the module number

$S_{2,m}$ indicates the output from present module set-2

$S_{2,m-1}$ indicates the set-2 output from previous module

Set 4 consists of cells, whose outputs control the select inputs of set_5 type cells in set 5, which in turn drive both the left bus and the right bus. For an set 5-type cell and the 4-b partition to which the cell belongs, bitwise

comparison outcomes from set 1 provide information about the more significant bits. The number of inputs in the set 4 type cells increases from left to right in each partition, ending with a fan-in of five. Thus, set 4 determine whether set 5 propagates the bitwise comparison codes or not.

$$S_{4m1} = S_{3,m-1}.D_1$$

$$S_{4m2} = S_{3,m-1}.D_2\overline{D_1}$$

$$S_{4m3} = S_{3,m-1}.D_3\overline{D_2}\overline{D_1}$$

$$S_{4m4} = S_{3,m-1}.D_4\overline{D_3}\overline{D_2}\overline{D_1}$$

Set 5 performs the functionality of a multiplexer that is it shows whether the bit from the input A is greater or vice versa set_5 gives 2 bit output. The select control input is based on the set_4 type cell output from set 4. We define the 2-b as the left-bit code l_i and the right-bit code r_i where all left-bit codes and all right-bit codes combine to form the left bus and the right bus, respectively. The output F denotes the “greater-than,” “less-than,” or “equal to” final comparison decision

$$S_{5iai} = s_{4i}(a_i)$$

$$S_{5ibi} = s_{4i}(b_i)$$

$$F = S_{5iai} S_{5ibi}$$

- 00, for $A_i = B_i$
- 01, for $A_i < B_i$
- 10, for $A_i > B_i$.

Essentially, the 2-b code F can be realized by OR-ing all left bits and all right bits separately, in the decision module using an OR-gate network.

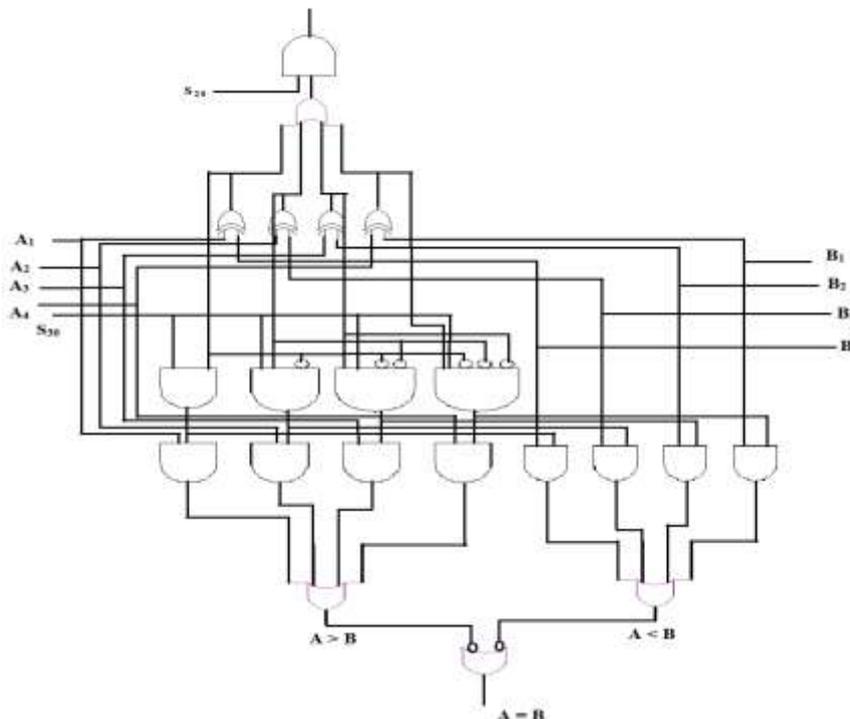


Figure4: Design of a single module (4-bit) comparator

IV. IMPLEMENTING 128 BIT COMPARATOR IN A SORTER

Sorting is a fundamental operation in which the given sequence of elements is arranged in a specific order. We see many applications of sorting in our daily life. If we consider a database of students in a college they are arranged in a sequence either in alphabetical order or roll number wise or date of admission etc., not only in colleges we can also see the applications of sorting in various scientific fields. The basic element in the sorting circuit is comparison element. We use a magnitude comparator as a key element in the sorting circuit. The

comparator compares two elements and produces three outputs greater than, less than and equal to. Based on these outputs the sorting circuit uses a swapping module so that the elements in the given sequence are sorted in a desired order.

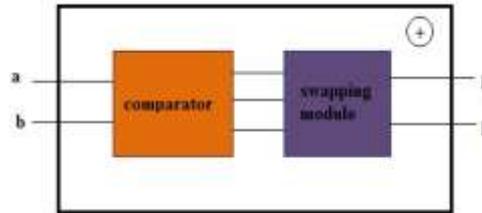


Figure5: Basic sorting I.O architecture

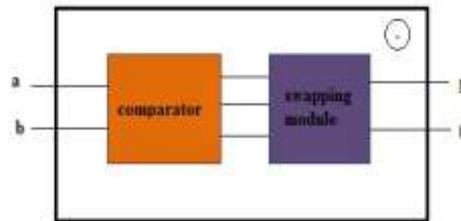


Figure6: Basic sorting D.O architecture

Bitonic sequence is a sequence that has one monotonic increasing sequence and one monotonic decreasing sequence. Because of the two monotonic sequences it is called bitonic sequence. Bitonic sorting divides the given n numbered sequence into two $n/2$ sequences out of which one is sorted in ascending order and the second $n/2$ sequence is sorted in descending order. Whether the increasing order sorting has to be performed first or decreasing order sorting has to be performed first depends on our sorting order. If at all we have to perform sorting in an increasing order then the first $n/2$ sequence is sorted in increasing order and the second $n/2$ sequence is sorted in the decreasing order. All the elements in the first $n/2$ sequence will be less than or equal to the elements in the second $n/2$ sequence. If at all we have to perform sorting in a decreasing order then the first $n/2$ sequence is sorted in decreasing order and the second $n/2$ sequence is sorted in the increasing order. All the elements in the first $n/2$ sequence will be greater than or equal to the elements in the second $n/2$ sequence. Then the two $n/2$ sequences are sorted using merge sort. The bitonic sorting network consists of two key elements. One is comparator element and the other is swapping element. The comparator compares two elements and produces three outputs greater than, less than and equal to. Based on these outputs the sorting circuit uses a swapping module so that the elements in the given sequence are sorted in a desired order.

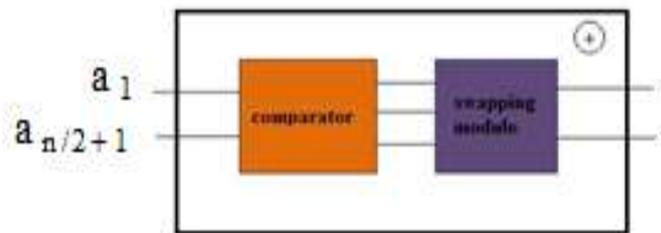


Figure7: General bitonic sorting module for increasing order sorting

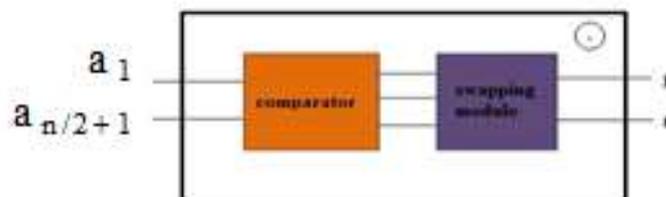


Figure8: General bitonic sorting module for decreasing order sorting

The general bitonic sorting to sort the elements in increasing order is performed as below

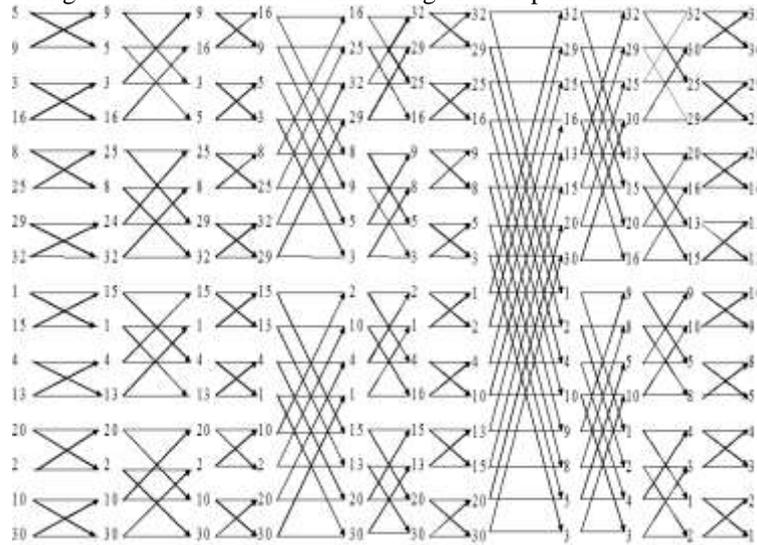


Figure9: Example for ascending order bitonic sorting

The general comparator module used in the sorting is replaced by the 1128 bit parallel prefix tree structure comparator and is as shown in the figure 10

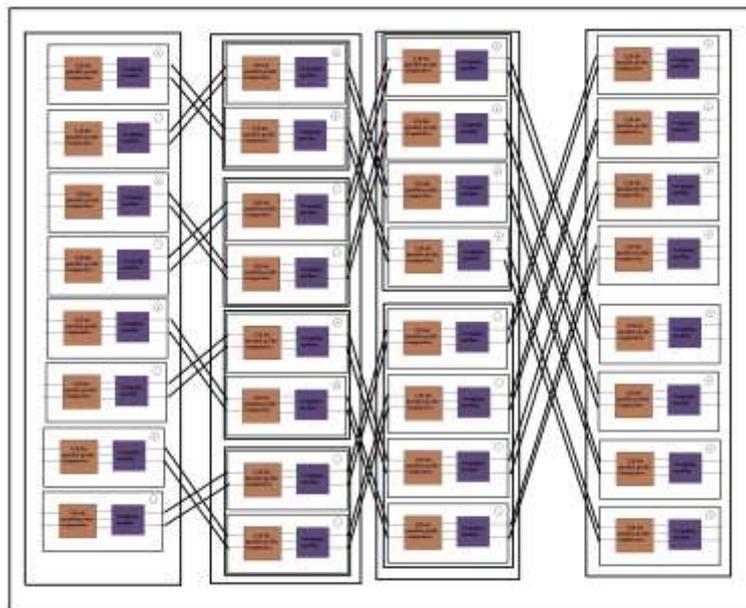


Figure10: Implementation of comparator in 16 numbered sequence bitonic sorter

V. RESULTS



Figure11: output of the comparator showing all the results $a > b$, $a = b$ & $a < b$

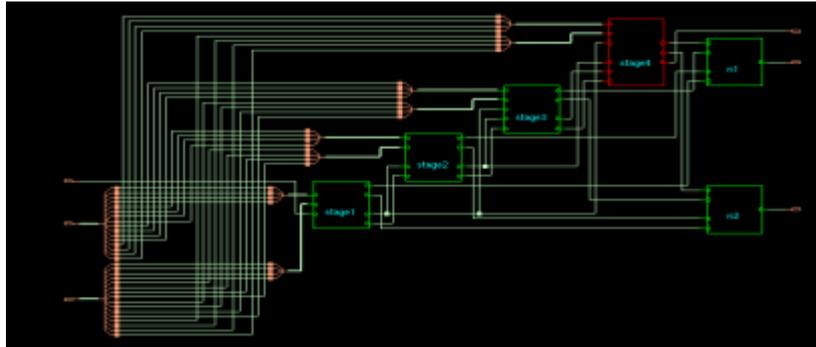


Figure12: RTL for 4 stages of comparator (16 bit)

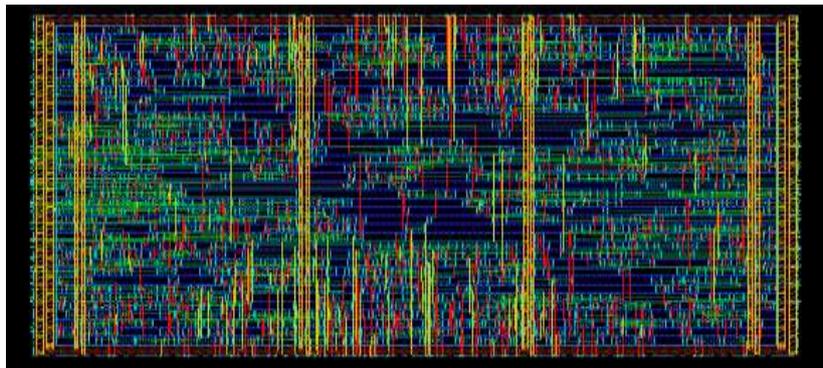


Figure13: Layout for 128 bit comparator

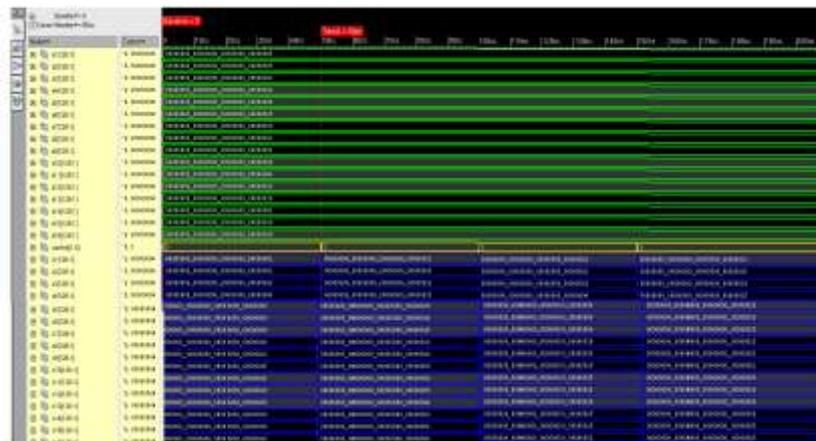


Figure14: simulation results for bitonic sorter performing 4 types of sorting orders

VI. POWER ANALYSIS

No of bits	Leakage power(μ w)	Dynamic power(mw)
16	0.05	0.03
32	0.1	0.07
48	0.16	0.11
64	0.22	0.14
80	0.27	0.17
96	0.33	0.21
112	0.38	0.25
128	0.44	0.28

Table: 1 power dissipation for various bit comparators

As the number of bits increases the power dissipated by the comparator architecture increases. The Power dissipated for various bits of comparators are shown below.

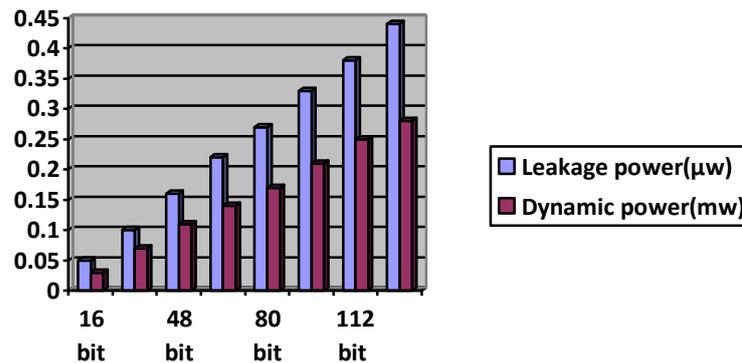


Figure15: power dissipation for various bits of comparator

VII. CONCLUSION

We have designed 128 bit comparator using parallel prefix tree architecture. This architecture consists of parallel structure which helps in replicating the design which supports VLSI reconfigurable topology. All the cells used in this architecture are logic gates which makes use of CMOS logic. The comparator dissipates a power of 0.2mW and has a delay of 0.5ms. By using this 128 bit comparator we designed a sorter that sorts 16 numbers in four different sorting orders using bitonic sorting method.

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